



RADIO TEST REPORT

Test Report No. : 13332968S-A-R1

Applicant : Alpine Electronics, Inc.
Type of EUT : Display Unit
Model Number of EUT : GABI04
FCC ID : A269ZUA162
Test regulation : FCC Part 15 Subpart C: 2020
Test Result : Complied (Refer to SECTION 3.2)

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3. This sample tested is in compliance with the limits of the above regulation.
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7. The all test items in this test report are conducted by UL Japan, Inc. Shonan EMC Lab.
8. The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan has been accredited.
9. The information provided from the customer for this report is identified in SECTION 1.
10. This report is a revised version of 13332968S-A. 13332968S-A is replaced with this report.

Date of test: May 1 to 14, 2020

Representative test engineer:

Shiro Kobayashi
Engineer

Consumer Technology Division

Approved by:

Hikaru Shirasawa
Engineer

Consumer Technology Division



CERTIFICATE 1266.03

- ☐ The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.
- ☒ There is no testing item of "Non-accreditation".

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Report Cover Page 13-EM-F0429 Issue # 16.0

REVISION HISTORY

Original Test Report No.: 13332968S-A

Revision	Test report No.	Date	Page revised	Contents
- (Original)	13332968S-A	May 27, 2020	-	-
1	13332968S-A-R1	June 16, 2020	9	Addition of remarks: “* Pre-check has been performed with Tag and without Tag, and measurement was conducted with the worst case with Tag.”
			11	Addition of description: “The limits in CFR 47, Part 15, Subpart C, paragraph 15.209(a), are identical to those in RSS-Gen section 8.9, Table 6, since the measurements are performed in terms of magnetic field strength and converted to electric field strength levels (as reported in the table) using the free space impedance of 377 Ohms. For example, the measurement at frequency X kHz resulted in a level of Y dBuV/m, which is equivalent to $Y - 51.5 = Z$ dBuA/m, which has the same margin, W dB, to the corresponding RSS-Gen Table 6 limit as it has to 15.209(a) limit.”
			20	Correction of unit: “1906.9 MHz” → “1906.9 kHz”
			22	Correction of typo: “Below 1 GHz” and “Above 1 GHz” → “Below 30 MHz” and “Above 30 MHz”

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Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	MCS	Modulation and Coding Scheme
AC	Alternating Current	MRA	Mutual Recognition Arrangement
AFH	Adaptive Frequency Hopping	N/A	Not Applicable
AM	Amplitude Modulation	NIST	National Institute of Standards and Technology
Amp, AMP	Amplifier	NS	No signal detect.
ANSI	American National Standards Institute	NSA	Normalized Site Attenuation
Ant, ANT	Antenna	NVLAP	National Voluntary Laboratory Accreditation Program
AP	Access Point	OBW	Occupied Band Width
ASK	Amplitude Shift Keying	OFDM	Orthogonal Frequency Division Multiplexing
Atten., ATT	Attenuator	P/M	Power meter
AV	Average	PCB	Printed Circuit Board
BPSK	Binary Phase-Shift Keying	PER	Packet Error Rate
BR	Bluetooth Basic Rate	PHY	Physical Layer
BT	Bluetooth	PK	Peak
BT LE	Bluetooth Low Energy	PN	Pseudo random Noise
BW	BandWidth	PRBS	Pseudo-Random Bit Sequence
Cal Int	Calibration Interval	PSD	Power Spectral Density
CCK	Complementary Code Keying	QAM	Quadrature Amplitude Modulation
Ch., CH	Channel	QP	Quasi-Peak
CISPR	Comite International Special des Perturbations Radioelectriques	QPSK	Quadri-Phase Shift Keying
CW	Continuous Wave	RBW	Resolution Band Width
DBPSK	Differential BPSK	RDS	Radio Data System
DC	Direct Current	RE	Radio Equipment
D-factor	Distance factor	RF	Radio Frequency
DFS	Dynamic Frequency Selection	RMS	Root Mean Square
DQPSK	Differential QPSK	RSS	Radio Standards Specifications
DSSS	Direct Sequence Spread Spectrum	Rx	Receiving
EDR	Enhanced Data Rate	SA, S/A	Spectrum Analyzer
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	SG	Signal Generator
EMC	ElectroMagnetic Compatibility	SVSWR	Site-Voltage Standing Wave Ratio
EMI	ElectroMagnetic Interference	TR	Test Receiver
EN	European Norm	Tx	Transmitting
ERP, e.r.p.	Effective Radiated Power	VBW	Video BandWidth
EU	European Union	Vert.	Vertical
EUT	Equipment Under Test	WLAN	Wireless LAN
Fac.	Factor		
FCC	Federal Communications Commission		
FHSS	Frequency Hopping Spread Spectrum		
FM	Frequency Modulation		
Freq.	Frequency		
FSK	Frequency Shift Keying		
GFSK	Gaussian Frequency-Shift Keying		
GNSS	Global Navigation Satellite System		
GPS	Global Positioning System		
Hori.	Horizontal		
ICES	Interference-Causing Equipment Standard		
IEC	International Electrotechnical Commission		
IEEE	Institute of Electrical and Electronics Engineers		
IF	Intermediate Frequency		
ILAC	International Laboratory Accreditation Conference		
ISED	Innovation, Science and Economic Development Canada		
ISO	International Organization for Standardization		
JAB	Japan Accreditation Board		
LAN	Local Area Network		
LIMS	Laboratory Information Management System		

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SECTION 1: Customer information

Company Name : Alpine Electronics, Inc.
Address : 20-1 Yoshima-Industrial Park, Iwaki, Fukushima 970-1192, Japan
Telephone Number : +81-246-36-4111
Facsimile Number : +81-246-36-6898
Contact Person : Nobuyuki Omi

The information provided from the customer is as follows;

- Applicant, Type of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer information
- SECTION 2: Equipment under test (EUT)
- SECTION 4: Operation of EUT during testing

* The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (E.U.T.)**2.1 Identification of E.U.T.**

Type of Equipment : Display Unit
Model No. : GABI04
Serial No. : Refer to Section 4, Clause 4.2
Rating : DC 13.5 V
Receipt Date of Sample : April 28, 2020
(Information from test lab.)
Country of Mass-production : Mexico
Condition of EUT : Production prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product description

Model: GABI04 (referred to as the EUT in this report) is a Display Unit.

General Specification

Clock frequency(ies) in the system : Ucom: 16 MHz/ NFC: 13.56 MHz/ Xta: 27.12 MHz

Radio Specification

Radio Type : Transceiver
Frequency of Operation : 13.56 MHz
Modulation : ASK
Antenna type : Loop
Operating Temperature : -40 deg.C to +85 deg C.

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SECTION 3: Test specification, procedures & results

3.1 Test specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on April 1, 2020 and effective June 1, 2020 except 15.258
* The revision does not affect the test result conducted before its effective date.

Title : FCC 47 CFR Part 15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.209 Radiated emission limits, general requirements
Section 15.215 Additional provisions to the general radiated emission limitations.
Section 15.225 Operation within the bands 13.110 - 14.010 MHz.

3.2 Procedures & Results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.10-2013 6. Standard test methods IC: RSS-Gen 8.8	FCC: Section 15.207 ----- IC: RSS-Gen 8.8	-	N/A *1)	-
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.10-2013 6. Standard test methods IC: RSS-Gen 6.4, 6.12	FCC: Section 15.225 (a) ----- IC: RSS-210 B.6	63.5 dB (Vertical)	Complied a)	Radiated
Electric Field Strength of Spurious Emission (within the 13.110-14.010 MHz band)	FCC: ANSI C63.10-2013 6. Standard test methods IC: RSS-Gen 6.4, 6.13	FCC: Section 15.225 (b)(c) ----- IC: RSS-210 B.6	42.8 dB (13.567 MHz, Vertical)	Complied a)	Radiated
Electric Field Strength of Spurious Emission (outside of the 13.110-14.010 MHz band)	FCC: ANSI C63.10-2013 6. Standard test methods IC: RSS-Gen 6.4, 6.13	FCC: Section 15.209 Section 15.225 (d) ----- IC: RSS-210 B.6	7.6 dB (40.68 MHz, Vertical)	Complied b)	Radiated
20 dB Bandwidth	FCC: ANSI C63.10-2013 6. Standard test methods IC: -	FCC: Section 15.215 (c) ----- IC: -	-	Complied c)	Radiated
Frequency tolerance	FCC: ANSI C63.10-2013 6. Standard test methods IC: RSS-Gen 6.11, 8.11	FCC: Section 15.225 (e) ----- IC: RSS-210 B.6	-	Complied d)	Radiated
Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422. *1) The test is not applicable since the EUT has no AC mains. a) Refer to APPENDIX 1 (data of Electric field strength of Fundamental emission and Spurious emission within the band) b) Refer to APPENDIX 1 (data of Radiated Emission) c) Refer to APPENDIX 1 (data of 20 dB Bandwidth, 99 % Occupied Bandwidth) d) Refer to APPENDIX 1 (data of Frequency Tolerance) Symbols: Complied The data of this test item has enough margin, more than the measurement uncertainty. Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.					

FCC Part 15.31 (e)

This EUT provides stable voltage constantly to RF part regardless of input voltage. Instead of a new battery, DC power supply was used for the test. That does not affect the test result. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the requirement.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % Occupied Bandwidth	IC: RSS-Gen 6.6	IC: -	N/A	- c)	Radiated
Note: UL Japan's EMI Work Procedures No.13-EM-W0420 and 13-EM-W0422. c) Refer to APPENDIX 1 (data of 20 dB Bandwidth, 99 %Occupied Bandwidth)					

* Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k=2$.

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Item	Frequency range	Uncertainty (+/-)			
		No. 1 SAC / SR	No. 2 SAC / SR	No. 3 SAC / SR	No. 4,5,6,8 SR
Conducted emission (AC Mains) LISN	150 kHz-30 MHz	2.6 dB	2.6 dB	2.5 dB	2.6 dB
Radiated emission (Measurement distance: 3 m)	9 kHz-30 MHz	3.0 dB	3.0 dB	3.0 dB	-
	30 MHz-200 MHz	4.6 dB	4.6 dB	4.6 dB	-
	200 MHz-1 GHz	6.0 dB	6.0 dB	6.0 dB	-
	1 GHz-6 GHz	4.9 dB	4.9 dB	4.9 dB	-
	6 GHz-18 GHz	5.5 dB	5.5 dB	5.5 dB	-
	18 GHz-40 GHz	5.4 dB	5.4 dB	5.4 dB	-
Radiated emission (Measurement distance: 1 m)	1 GHz-18 GHz	5.8 dB	5.8 dB	5.8 dB	-
	18 GHz-40 GHz	5.7 dB	5.7 dB	5.7 dB	-

SAC=Semi-Anechoic Chamber

SR= Shielded Room is applied besides radiated emission

Antenna terminal test	Uncertainty (+/-)
Power Measurement above 1 GHz (Average Detector)_SPM-06	0.98 dB
Power Measurement above 1 GHz (Peak Detector)_SPM-06	1.75 dB
Power Measurement above 1 GHz (Average Detector)_SPM-07	0.89 dB
Power Measurement above 1 GHz (Peak Detector)_SPM-07	1.12 dB
Power Measurement above 1 GHz (Average Detector)_SPM-13	1.06 dB
Power Measurement above 1 GHz (Peak Detector)_SPM-13	1.24 dB
Spurious emission (Conducted) below 1GHz	0.9 dB
Spurious emission (Conducted) 1 GHz-3 GHz	0.9 dB
Spurious emission (Conducted) 3 GHz-18 GHz	2.9 dB
Spurious emission (Conducted) 18 GHz-26.5 GHz	2.6 dB
Spurious emission (Conducted) 26.5 GHz-40 GHz	2.0 dB
Bandwidth Measurement	0.07 %
Duty cycle and Time Measurement	0.262 %
Temperature	0.95 deg.C.
Voltage	0.83 %

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3.5 Test location

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A2LA Certificate Number: 1266.03 (FCC Test Firm Registration Number: 626366, ISED Lab Company Number: 2973D)

Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
No.1 Semi-anechoic chamber	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.2 Semi-anechoic chamber	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.3 Semi-anechoic chamber	12.7 x 7.7 x 5.35	12.7 x 7.7	5 m
No.4 Semi-anechoic chamber	8.1 x 5.1 x 3.55	8.1 x 5.1	-
No.1 Shielded room	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.2 Shielded room	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.3 Shielded room	6.3 x 4.7 x 2.7	6.3 x 4.7	-
No.4 Shielded room	4.4 x 4.7 x 2.7	4.4 x 4.7	-
No.5 Shielded room	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.6 Shielded room	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.8 shielded room	3.45 x 5.5 x 2.4	3.45 x 5.5	-
No.1 Measurement room	2.55 x 4.1 x 2.5	-	-

3.6 Test setup, Data of EMI & Test instruments

Refer to APPENDIX.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating mode

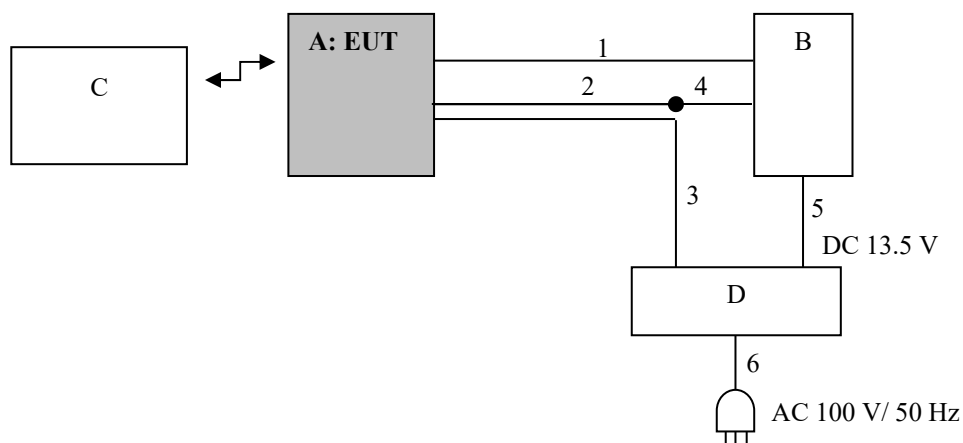
The EUT exercise program used during testing was designed to exercise the various system components in a manner similar to typical use.

Test sequence is used: Transmitting (13.56 MHz)

Power settings	Fixed
Software	ZERV ICS
Version	Ver. 1.0081
Date	May 1, 2020

Justification: The system was configured in typical fashion (as a customer would normally use it) for testing.

4.2 Configuration of tested system



* Test data was taken under worse case conditions.

* Pre-check has been performed with Tag and without Tag, and measurement was conducted with the worst case with Tag.

Description of EUT and support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Display Unit	GABI04	1	Alpine Electronics, Inc.	EUT
B	CAN BOX	-	-	Alpine Electronics, Inc.	-
C	Tag	NFC Forum Type2	1403871969954432	-	-
D	Power Supply(DC)	PAN35-10A	NA000955	KIKUSUI	-

List of cables used

No.	Cable	Length (m)	Shield-Cable	Shield-Connector	Remarks
1	Signal	5.1	Unshielded	Unshielded	-
2	Signal	5.1	Unshielded	Unshielded	-
3	DC	5.1	Unshielded	Unshielded	-
4	Signal	0.45	Unshielded	Unshielded	-
5	DC	0.3	Unshielded	Unshielded	-
6	AC	2.0	Unshielded	Unshielded	-

SECTION 5: Radiated emission

5.1 Operating environment

Test place : See test data (APPENDIX 1)

Temperature : See test data (APPENDIX 1)

Humidity : See test data (APPENDIX 1)

5.2 Test configuration

EUT was placed on a platform of nominal size, 1.0 m by 1.5 m, raised 80 cm above the conducting ground plane. That has very low permittivity.

Photographs of the set up are shown in APPENDIX 3.

5.3 Test procedure

The Radiated Electric Field Strength intensity has been measured on a semi-anechoic chamber with a ground plane at a distance of 3 m.

Although these tests were performed other than open area test site, adequate comparison measurements were confirmed against 30 m open area test site. Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 414788. These tests were performed in semi anechoic chamber. Therefore the measured level of emissions may be higher than if measurements were made without a ground plane. However test results were confirmed to pass against standard limit.

The Radiated Electric Field Strength intensity has been measured with a ground plane and at a distance of 3 m.

Frequency: From 9 kHz to 30 MHz at distance 3 m (Refer to Figure 2)

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for vertical polarization (antenna angle: 0 deg., 45 deg., 90 deg. and 135 deg.) and horizontal polarization. Drawing of the antenna direction is shown in Figure 1.

Frequency: From 30 MHz to 1 GHz at distance 3 m (Refer to Figure 2).

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

Measurements were performed with QP, PK, and AV detector.

The radiated emission measurements were made with the following detector function of the test receiver.

	9 kHz to 90 kHz & 110 kHz to 150 kHz	90 kHz to 110 kHz	150 kHz to 490 kHz	490 kHz to 30 MHz	30 MHz to 1 GHz
Detector Type	PK/AV	QP	PK/AV	QP	QP
IF Bandwidth	200 Hz	200 Hz	10 kHz	9 kHz	120 kHz
Distance factor *1)	-80 dB	-80 dB	-80 dB	-40 dB	-
Measuring antenna	Loop antenna				Biconical (30 MHz - 199.99 MHz) Logperiodic (200 MHz - 1 GHz)

*1) FCC 15.31 (f)(2) (9 kHz-30 MHz)

Distance Factor: $40 \times \log (3 \text{ m} / 300 \text{ m}) = -80 \text{ dB}$

Distance Factor: $40 \times \log (3 \text{ m} / 30 \text{ m}) = -40 \text{ dB}$

The EUT was set at 82.3 degree (on the condition that the horizontal plane is set to 0 deg.) as normal position according to the EUT's specification.

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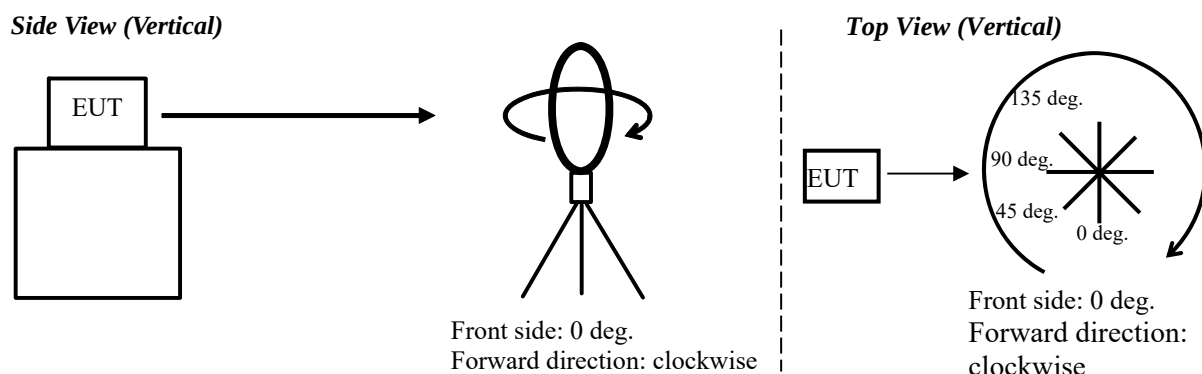
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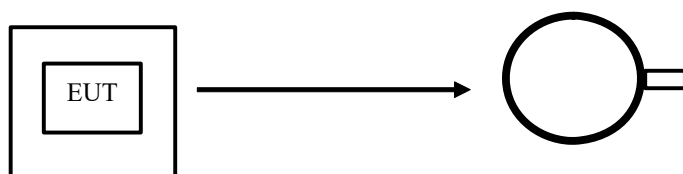
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The limits in CFR 47, Part 15, Subpart C, paragraph 15.209(a), are identical to those in RSS-Gen section 8.9, Table 6, since the measurements are performed in terms of magnetic field strength and converted to electric field strength levels (as reported in the table) using the free space impedance of 377 Ohms. For example, the measurement at frequency X kHz resulted in a level of Y dBuV/m, which is equivalent to $Y - 51.5 = Z$ dBuA/m, which has the same margin, W dB, to the corresponding RSS-Gen Table 6 limit as it has to 15.209(a) limit.

Figure 1: Direction of the Loop Antenna

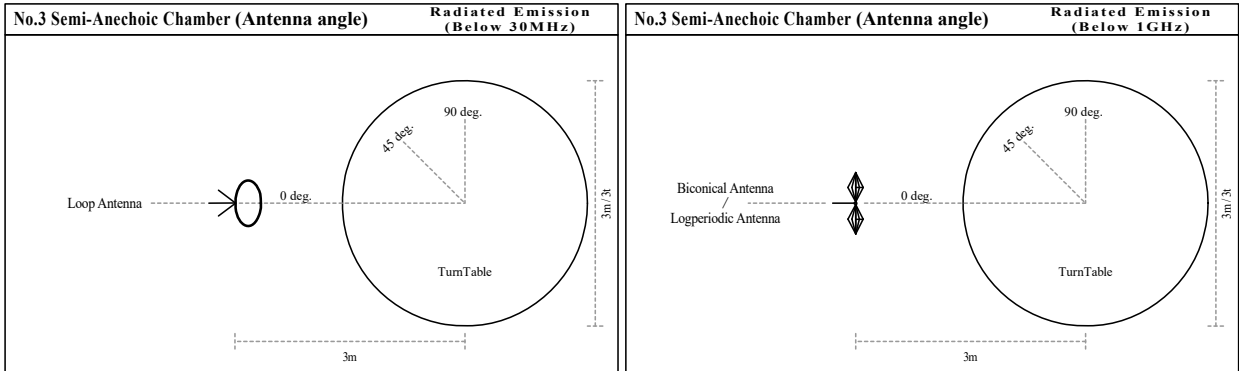


Top View (Horizontal)

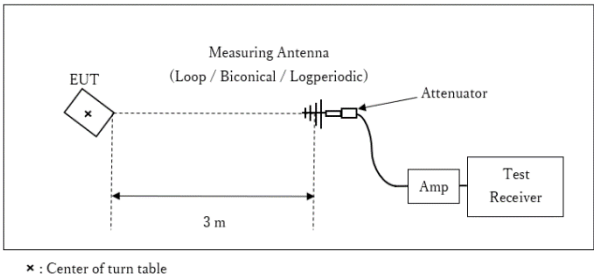


Antenna was not rotated.

Figure 2. Antenna angle



[Test Setup]
Below 1 GHz



Test Distance: 3 m

5.4 Results

Summary of the test results : Pass

Refer to APPENDIX 1

SECTION 6: 20 dB bandwidth & 99 % Occupied bandwidth

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	2 to 5 times of OBW	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	Enough width to display measured Bandwidth	1 to 5 % of Span	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer

Summary of the test results:Pass

Refer to APPENDIX 1

SECTION 7: Frequency Tolerance**Test procedure**

The test was measured with a frequency counter using a test fixture.

The temperature test was started after the temperature stabilization time of 30 minutes.

The test was begun from 50 deg.C and the temperature was lowered each 10 deg.C.

Summary of the test results:Pass

Refer to APPENDIX 1

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APPENDIX 1: Data of Radio tests

Data of Electric field strength of Fundamental emission and Spurious emission within the band: FCC15.225(a)(b)(c)

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Shonan EMC Lab., No.3 Semi Anechoic Chamber

Company: Alpine Electronics, Inc.
 Equipment: Display Unit
 Model: GABI04
 Sample No.: 1
 Power: DC 13.5 V
 Mode: Transmitting 13.56 MHz

Regulation: FCC Part15 Subpart C 15.225
 Test Distance: 3 m
 Date: May 01, 2020
 Temperature: 23 deg.C
 Humidity: 43 %RH
 ENGINEER: Shiro Kobayashi

Remarks: : Tag Type 2, Vertical polarization (antenna angle) of the worst case: 0 deg

Fundamental emission

No.	FREQ [MHz]	Test Receiver Reading		Antenna Factor [dB/m]	Loss [dB]	AMP GAIN [dB]	Distance factor [dB]	RESULT		LIMIT (30m) [dBuV/m]	MARGIN	
		Hor [dBuV]	Ver [dBuV]					Hor [dBuV/m]	Ver [dBuV/m]		Hor [dB]	Ver [dB]
1	13.560	58.37	65.29	20.91	6.36	32.19	-40.00	13.45	20.37	83.9	70.4	63.5

Calculation: Result[dBuV/m] = Reading[dBuV] + Ant.Fac[dB/m] + Loss(Cable+ATT)[dB] - Gain(AMP)[dB] + Distance factor[dB]

Distance factor: $40 \times \log(3 \text{ m}/30 \text{ m}) = -40 \text{ dB}$

Limits (30 m)

• 13.553 MHz to 13.567 MHz : 83.9 dBuV/m (FCC 15.225(a))

Spurious emission within the band

No.	FREQ [MHz]	Test Receiver Reading		Antenna Factor [dB/m]	Loss [dB]	AMP GAIN [dB]	Distance factor [dB]	RESULT		LIMIT (30m) [dBuV/m]	MARGIN	
		Hor [dBuV]	Ver [dBuV]					Hor [dBuV/m]	Ver [dBuV/m]		Hor [dB]	Ver [dB]
1	13.110	30.46	30.48	20.84	6.36	32.19	-40.00	-14.53	-14.51	29.5	44.0	44.0
2	13.348	34.64	40.02	20.88	6.36	32.19	-40.00	-10.31	-4.93	40.5	50.8	45.4
2	13.349	34.41	40.06	20.88	6.36	32.19	-40.00	-10.54	-4.89	40.5	51.0	45.3
3	13.410	30.94	33.06	20.89	6.36	32.19	-40.00	-14.00	-11.88	40.5	54.5	52.3
4	13.456	31.98	35.91	20.90	6.36	32.19	-40.00	-12.95	-9.02	50.4	63.3	59.4
4	13.456	31.84	36.06	20.90	6.36	32.19	-40.00	-13.09	-8.87	50.4	63.4	59.2
5	13.553	42.68	49.28	20.91	6.36	32.19	-40.00	-2.24	4.36	50.4	52.6	46.0
6	13.567	45.70	52.48	20.91	6.36	32.19	-40.00	0.78	7.56	50.4	49.6	42.8
7	13.668	31.98	36.13	20.93	6.37	32.19	-40.00	-12.91	-8.76	50.4	63.3	59.1
8	13.669	32.01	36.17	20.93	6.37	32.19	-40.00	-12.88	-8.72	50.4	63.2	59.1
9	13.710	30.89	33.24	20.94	6.37	32.19	-40.00	-13.99	-11.64	40.5	54.4	52.1
9	13.771	32.68	40.49	20.95	6.37	32.19	-40.00	-12.19	-4.38	40.5	52.6	44.8
10	13.772	34.86	40.56	20.95	6.37	32.19	-40.00	-10.01	-4.31	40.5	50.5	44.8
11	14.010	30.47	30.56	20.98	6.37	32.19	-40.00	-14.37	-14.28	29.5	43.8	43.7

Calculation: Result[dBuV/m] = Reading[dBuV] + Ant.Fac[dB/m] + Loss(Cable+ATT)[dB] - Gain(AMP)[dB] + Distance factor[dB]

Outside filed strength frequencies

- $F_c \pm 7 \text{ kHz}$: 13.553 MHz to 13.567 MHz
- $F_c \pm 150 \text{ kHz}$: 13.410 MHz to 13.710 MHz
- $F_c \pm 450 \text{ kHz}$: 13.110 MHz to 14.010 MHz
- $F_c = 13.56 \text{ MHz}$

Limits (30 m)

- 13.410 MHz to 13.553 MHz and 13.567 MHz to 13.710 MHz : 50.4 dBuV/m (FCC 15.225(b))
- 13.110 MHz to 13.410 MHz and 13.710 MHz to 14.010 MHz : 40.5 dBuV/m (FCC 15.225(c))
- Below 13.110 MHz and Above 14.010 MHz : 29.5 dBuV/m (FCC 15.225(d) and FCC 15.209)

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Radiated Emission

UL Japan, Inc.

Shonan EMC Lab. No.3 Semi Anechoic Chamber

Company: Alpine Electronics, Inc.

Equipment: Display Unit

Model: GABI04

Sample No.: 1

Power: DC 13.5 V

Mode: Transmitting 13.56 MHz

EUT axis: Below 30 MHz, Tag Type 2, Vertical polarization (antenna angle) of the worst case: 90 deg

Above 30 MHz, Tag Type 2

Remarks:

Regulation: FCC Part15 Subpart C 15.225

Test Distance: 3 m

Date: May 01, 2020

Temperature: 23 deg.C

Humidity: 43 %RH

ENGINEER: Shiro Kobayashi

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Distance Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	27.12	QP	29.82	22.33	6.62	32.18	-40.0	-13.41	29.5	42.9	-	10	* Limit: 30m
Hori.	40.68	QP	28.86	14.45	6.65	32.17	0.0	17.79	40.0	22.2	256	167	
Hori.	149.17	QP	28.04	14.72	7.74	32.08	0.0	18.42	43.5	25.0	221	181	
Hori.	185.500	QP	28.55	16.39	7.79	32.05	0.0	20.68	43.5	22.8	181	194	
Hori.	195.290	QP	22.38	16.52	7.80	32.05	0.0	14.65	43.5	28.8	167	266	
Hori.	257.65	QP	23.85	12.05	8.30	31.98	0.0	12.22	46.0	33.7	117	191	
Hori.	406.812	QP	37.99	15.79	9.03	31.93	0.0	30.88	46.0	15.1	232	179	
Hori.	881.420	QP	21.87	22.11	10.76	31.15	0.0	23.59	46.0	22.4	165	132	
Vert.	27.12	QP	35.05	22.33	6.62	32.18	-40.00	-8.18	29.5	37.6	-	15	* Limit: 30m
Vert.	40.68	QP	43.38	14.45	6.65	32.17	0.00	32.31	40.0	7.6	100	87	
Vert.	54.24	QP	43.84	9.80	6.74	32.16	0.00	28.22	40.0	11.7	100	340	
Vert.	67.802	QP	41.56	6.80	6.62	32.15	0.00	22.83	40.0	17.1	100	222	
Vert.	81.362	QP	42.89	6.41	7.56	32.15	0.00	24.71	40.0	15.2	108	151	
Vert.	94.923	QP	34.93	9.09	7.44	32.14	0.00	19.32	43.5	24.1	100	280	
Vert.	153.930	QP	22.57	14.91	7.81	32.08	0.00	13.21	43.5	30.2	100	189	
Vert.	176.280	QP	23.08	16.17	7.81	32.06	0.00	15.00	43.5	28.5	100	213	
Vert.	185.500	QP	30.18	16.39	7.79	32.05	0.00	22.31	43.5	21.1	100	261	
Vert.	257.65	QP	24.23	12.05	8.30	31.98	0.00	12.60	46.0	33.4	150	308	
Vert.	865.66	QP	23.56	21.92	10.72	31.23	0.00	24.97	46.0	21.0	114	25	

Result = Reading + Ant Factor + Loss (Cable+ATT+ΔAF(above 30 MHz)) - Gain(Ampriifier) + Distance factor(below 30 MHz)

* Other frequency noises omitted in this report were not seen or have enough margin (more than 20 dB).

* Carrier level (Result at 3 m): Hor= 53.5 dBuV/m, Ver= 60.4 dBuV/m

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Radiated Emission (Worst mode plot)

UL Japan, Inc.

Shonan EMC Lab. No.3 Semi Anechoic Chamber

Company: Alpine Electronics, Inc.

Equipment: Display Unit

Model: GABI04

Sample No.: 1

Power: DC 13.5 V

Mode: Transmitting 13.56 MHz

EUT axis: Below 30 MHz, Tag Type 2, Vertical polarization (antenna angle) of the worst case: 90 deg

Above 30 MHz, Tag Type 2

Remarks: These plots data contains sufficient number to show the trend of characteristic features for EUT.

Regulation: FCC Part15 Subpart C 15.225

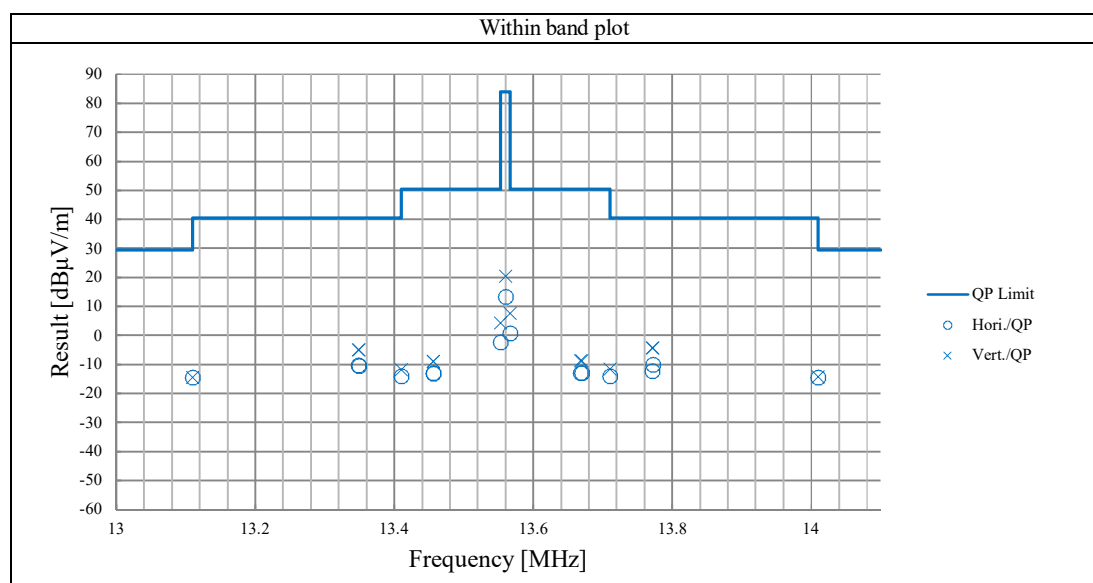
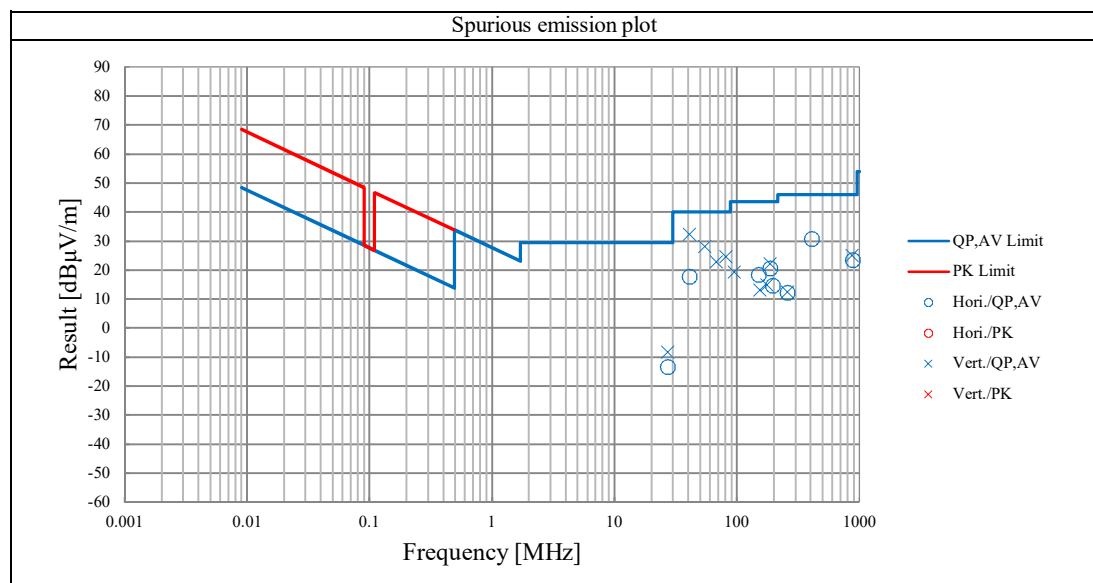
Test Distance: 3 m

Date: May 01, 2020 May 08, 2020

Temperature: 23 deg.C 22 deg.C

Humidity: 43 %RH 40 %RH

ENGINEER: Shiro Kobayashi Shiro Kobayashi



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Data of Frequency Tolerance

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded room

Company Alpine Electronics, Inc.
 Equipment Display Unit
 Model GABI04
 Serial No. 1
 Power DC 13.5 V
 Mode Transmitting 13.56 MHz

Regulation FCC Part15 Subpart C 15.225 (e)
 Date May 13, 2020
 Temperature 21 deg.C
 Humidity 50 %RH
 ENGINEER Toshinori Yamada

Temperature Variation: -20 deg.C

Test Conditions	Original Frequency (MHz)	Measure Frequency (MHz)	Frequency Error (MHz)	Frequency tolerance (%)	Limit (%)
startup	13.56	13.560395	0.000395	0.00292	0.010
after 2 minutes	13.56	13.560415	0.000415	0.00306	0.010
after 5 minutes	13.56	13.560393	0.000393	0.00290	0.010
after 10 minutes	13.56	13.560441	0.000441	0.00325	0.010

Temperature Variation: -10 deg.C

Test Conditions	Original Frequency (MHz)	Measure Frequency (MHz)	Frequency Error (MHz)	Frequency tolerance (%)	Limit (%)
startup	13.56	13.560511	0.000511	0.00377	0.010
after 2 minutes	13.56	13.560500	0.000500	0.00369	0.010
after 5 minutes	13.56	13.560458	0.000458	0.00338	0.010
after 10 minutes	13.56	13.560453	0.000453	0.00334	0.010

Temperature Variation: 0 deg.C

Test Conditions	Original Frequency (MHz)	Measure Frequency (MHz)	Frequency Error (MHz)	Frequency tolerance (%)	Limit (%)
startup	13.56	13.560406	0.000406	0.00300	0.010
after 2 minutes	13.56	13.560429	0.000429	0.00317	0.010
after 5 minutes	13.56	13.560444	0.000444	0.00327	0.010
after 10 minutes	13.56	13.560418	0.000418	0.00308	0.010

Temperature Variation: 10 deg.C

Test Conditions	Original Frequency (MHz)	Measure Frequency (MHz)	Frequency Error (MHz)	Frequency tolerance (%)	Limit (%)
startup	13.56	13.560428	0.000428	0.00315	0.010
after 2 minutes	13.56	13.560427	0.000427	0.00315	0.010
after 5 minutes	13.56	13.560504	0.000504	0.00372	0.010
after 10 minutes	13.56	13.560366	0.000366	0.00270	0.010

Temperature Variation: 20 deg.C

Test Conditions	Original Frequency (MHz)	Measure Frequency (MHz)	Frequency Error (MHz)	Frequency tolerance (%)	Limit (%)
startup	13.56	13.560497	0.000497	0.00366	0.010
after 2 minutes	13.56	13.560469	0.000469	0.00346	0.010
after 5 minutes	13.56	13.560421	0.000421	0.00311	0.010
after 10 minutes	13.56	13.560390	0.000390	0.00287	0.010

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Data of Frequency Tolerance

Temperature Variation: 30 deg.C

Test Conditions	Original Frequency (MHz)	Measure Frequency (MHz)	Frequency Error (MHz)	Frequency tolerance (%)	Limit (%)
startup	13.56	13.560443	0.000443	0.00327	0.010
after 2 minutes	13.56	13.560466	0.000466	0.00344	0.010
after 5 minutes	13.56	13.560481	0.000481	0.00355	0.010
after 10 minutes	13.56	13.560437	0.000437	0.00323	0.010

Temperature Variation: 40 deg.C

Test Conditions	Original Frequency (MHz)	Measure Frequency (MHz)	Frequency Error (MHz)	Frequency tolerance (%)	Limit (%)
startup	13.56	13.560387	0.000387	0.00286	0.010
after 2 minutes	13.56	13.560354	0.000354	0.00261	0.010
after 5 minutes	13.56	13.560369	0.000369	0.00272	0.010
after 10 minutes	13.56	13.560366	0.000366	0.00270	0.010

Temperature Variation: 50 deg.C

Test Conditions	Original Frequency (MHz)	Measure Frequency (MHz)	Frequency Error (MHz)	Frequency tolerance (%)	Limit (%)
startup	13.56	13.560420	0.000420	0.00310	0.010
after 2 minutes	13.56	13.560287	0.000287	0.00212	0.010
after 5 minutes	13.56	13.560337	0.000337	0.00248	0.010
after 10 minutes	13.56	13.560326	0.000326	0.00240	0.010

Data of Frequency Tolerance

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded room

Company Alpine Electronics, Inc.
 Equipment Display Unit
 Model GABI04
 Serial No. 1
 Power DC 13.5 V
 Mode Transmitting 13.56 MHz

Regulation FCC Part15 Subpart C 15.225 (e)
 Date May 13, 2020
 Temperature 21 deg.C
 Humidity 50 %RH
 ENGINEER Toshinori Yamada

Voltage Variation: DC 11.475 V**Temperature Variation: 20 deg.C**

Test Conditions	Original Frequency (MHz)	Measure Frequency (MHz)	Frequency Error (MHz)	Frequency tolerance (%)	Limit (%)
startup	13.56	13.560420	0.000420	0.00310	0.010
after 2 minutes	13.56	13.560463	0.000463	0.00342	0.010
after 5 minutes	13.56	13.560473	0.000473	0.00349	0.010
after 10 minutes	13.56	13.560389	0.000389	0.00287	0.010

Voltage Variation: DC 15.525 V**Temperature Variation: 20 deg.C**

Test Conditions	Original Frequency (MHz)	Measure Frequency (MHz)	Frequency Error (MHz)	Frequency tolerance (%)	Limit (%)
startup	13.56	13.560403	0.000403	0.00297	0.010
after 2 minutes	13.56	13.560410	0.000410	0.00303	0.010
after 5 minutes	13.56	13.560460	0.000460	0.00339	0.010
after 10 minutes	13.56	13.560448	0.000448	0.00330	0.010

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20dB bandwidth & 99% Occupied bandwidth: FCC 15.215 / RSS-Gen

UL Japan, Inc.

Shonan EMC Lab. No.5 Shielded Room

Company: Alpine Electronics, Inc.
Equipment: Display Unit
Model: GABI04
Sample No.: 1
Power: DC 13.5 V
Mode: Transmitting 13.56 MHz

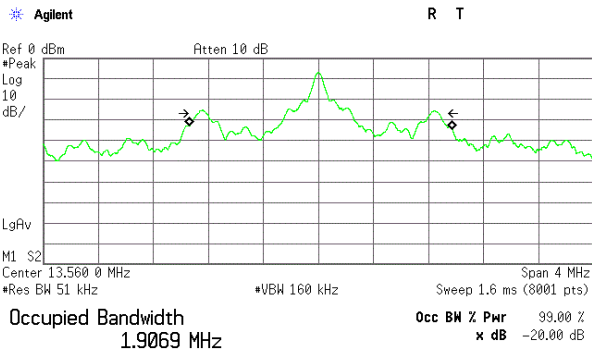
Regulation: FCC Part15 Subpart C 15.215

Date: May 14, 2020

Temperature: 24 deg.C

Humidity: 46 %RH

ENGINEER: Toshinori Yamada

Tag: Type 2**20 dB Bandwidth:** 1757.0 kHz**99 % Occupied Bandwidth:** 1906.9 kHz

Transmit Freq Error 18.967 kHz
x dB Bandwidth 1.757 MHz

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APPENDIX 2: Test instruments

Test Instruments

Test Name	Local ID	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Interval (Month)
FT	SCH-01	145200	Temperature and Humidity Chamber	ESPEC	PL-1KT	14020837	2020/04/02	12
FT、BW	KSA-08	145089	Spectrum Analyzer	Keysight Technologies Inc	E4446A	MY46180525	2019/11/05	12
FT、BW	KTS-07	145111	Digital Tester	SANWA	PC500	7019232	2019/10/01	12
FT、BW	SOS-27	191845	Humidity Indicator	CUSTOM	CTH-201	-	2019/12/12	12
FT、BW	SSCA-01	146178	Search coil	Langer	RF-R 400-1	02-0634	-	-
RE	COTS-SEMI-5	170932	EMI Software	TSJ	TEPTO-DV3(R E,CE,ME,PE)	-	-	-
RE	KBA-01	146343	Biconical Antenna	Schwarzbeck Mess - Elektronik	BBA9106	1748	2019/06/05	12
RE	KJM-02	146432	Measure	TAJIMA	GL19-55	-	-	-
RE	SAEC-03 (NSA)	145565	Semi-Anechoic Chamber	TDK	SAEC-03(NSA)	3	2020/04/12	12
RE	SAF-03	145126	Pre Amplifier	SONOMA	310N	290213	2020/02/19	12
RE	SAT6-13	167094	Attenuator	JFW	50HF-006N	-	2020/02/21	12
RE	SAT6-15	167096	Attenuator	JFW	50HF-006N	-	2020/02/21	12
RE	SCC-C1/C2/C3/C4/C5/C10/SRSE-03	145171	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhner/Suhner/TOYO	8D2W/12DSFA/141PE/141PE/141PE/141PE/NS 4906	-/0901-271(RF Selector)	2020/04/12	12
RE	SCC-M1	194601	Coaxial Cable	Fujikura	5D-2W	-	2019/12/17	12
RE	SLA-06	145528	Logperiodic Antenna	Schwarzbeck Mess - Elektronik	VUSLP9111B	195	2020/04/04	12
RE	SOS-23	191840	Humidity Indicator	CUSTOM	CTH-201	-	2019/12/12	12
RE	STR-08	150463	Test Receiver	Rohde & Schwarz	ESW44	101581	2019/11/22	12
RE	STS-03	146210	Digital Hitester	Hioki	3805-50	80997823	2019/10/01	12
RE	TLP-05	174863	Loop Antenna	Rohde & Schwarz	HFH2-Z2	826532/009	2019/11/12	12

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test item: FT: Frequency Tolerance
 BW: Bandwidth
 RE: Radiated Emission test